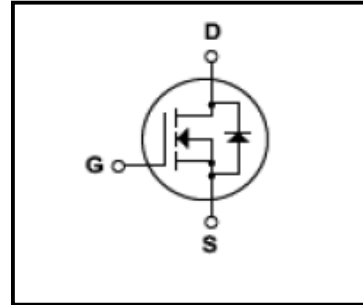


## Silicon N-Channel MOSFET

### Features

- 33A,100V, $R_{DS(on)}$ (Max0.044 $\Omega$ )@ $V_{GS}=10V$
- Ultra-low Gate charge(Typical 25nC)
- Fast Switching Capability
- 100%Avalanche Tested
- Isolation Voltage ( $V_{ISO}=4000V$  AC)
- Maximum Junction Temperature Range(150 $^{\circ}C$ )



### General Description

This Power MOSFET is produced using Winsemi's advanced planar stripe, DMOS technology. this latest technology has been especially designed to minimize on-state resistance, have a high rugged avalanche characteristics .This devices is specially well suited for half bridge and full bridge resonant topology line a electronic lamp ballast, high efficiency switched mode power supplies, active power factor correction.



### Absolute Maximum Ratings

Symbol	Parameter	Value	Units
$V_{DSS}$	Drain Source Voltage	100	V
$I_D$	Continuous Drain Current(@ $T_c=25^{\circ}C$ )	33*	A
	Continuous Drain Current(@ $T_c=100^{\circ}C$ )	23*	A
$I_{DM}$	Drain Current Pulsed (Note1)	132	A
$V_{GS}$	Gate to Source Voltage	$\pm 30$	V
$E_{AS}$	Single Pulsed Avalanche Energy (Note2)	435	mJ
$E_{AR}$	Repetitive Avalanche Energy (Note1)	12.7	mJ
dv/dt	Peak Diode Recovery dv /dt (Note3)	6.0	V/ ns
$P_D$	Total Power Dissipation(@ $T_c=25^{\circ}C$ )	127	W
	Derating Factor above 25 $^{\circ}C$	0.85	W/ $^{\circ}C$
$T_J, T_{stg}$	Junction and Storage Temperature	-40~150	$^{\circ}C$
$T_L$	Channel Temperature	300	$^{\circ}C$

\*Drain current limited by junction temperature

### Thermal Characteristics

Symbol	Parameter	Value			Units
		Min	Typ	Max	
$R_{QJC}$	Thermal Resistance , Junction -to -Case	-	-	1.18	$^{\circ}C/W$
$R_{QJA}$	Thermal Resistance , Junction-to -Ambient	-	-	62.5	$^{\circ}C/W$

**Electrical Characteristics(Tc=25°C)**

Characteristics		Symbol	Test Condition	Min	Type	Max	Unit
Gate leakage current		$I_{GSS}$	$V_{GS}=\pm 30V, V_{DS}=0V$	-	-	$\pm 100$	nA
Gate-source breakdown voltage		$V_{(BR)GSS}$	$I_G=\pm 10 \mu A, V_{DS}=0V$	$\pm 30$	-	-	V
Drain cut -off current		$I_{DSS}$	$V_{DS}=100V, V_{GS}=0V, T_c=25^\circ C$	-	-	1	$\mu A$
			$V_{DS}=80V, T_c=150^\circ C$	-	-	10	$\mu A$
Drain -source breakdown voltage		$V_{(BR)DSS}$	$I_D=250 \mu A, V_{GS}=0V$	100	-	-	V
Breakdown Voltage Temperature Coefficient		$\Delta BV_{DSS}/\Delta T_J$	$I_D=250 \mu A$ , referenced to 25°C	-	0.11	-	V/°C
Gate threshold voltage		$V_{GS(th)}$	$V_{DS}=V_{GS}, I_D=250 \mu A$	2	-	4	V
Drain -source ON resistance		$R_{DS(ON)}$	$V_{GS}=10V, I_D=16.5A$	-	-	0.044	$\Omega$
Forward Transconductance		$g_{fs}$	$V_{DS}=40V, I_D=16.5A$	-	22	-	S
Input capacitance		$C_{iss}$	$V_{DS}=25V,$ $V_{GS}=0V,$ $f=1MHz$	-	1150	1500	pF
Reverse transfer capacitance		$C_{rss}$		-	62	80	
Output capacitance		$C_{oss}$		-	320	420	
Switching time	Turn-On Rise time	$t_r$	$V_{DD}=50V,$ $I_D=33A$ $R_G=25\Omega$  (Note4,5)	-	195	400	ns
	Turn-On time	$T_d(on)$		-	15	40	
	Turn-Off Fall time	$t_f$		-	110	230	
	Turn-Off time	$T_d(off)$		-	80	170	
Total gate charge(gate-source plus gate-drain)		$Q_g$	$V_{DD}=80V,$ $V_{GS}=10V,$ $I_D=33A$  (Note4,5)	-	38	51	nC
Gate-source charge		$Q_{gs}$		-	7.5	-	
Gate-drain("miller") Charge		$Q_{gd}$		-	18	-	

**Source-Drain Ratings and Characteristics(Ta=25°C)**

Characteristics		Symbol	Test Condition	Min	Type	Max	Unit
Continuous drain reverse current		$I_{DR}$	-	-	-	33	A
Pulse drain reverse current		$I_{DRP}$	-	-	-	132	A
Forward voltage(diode)		$V_{DSF}$	$I_{DR}=7.5A, V_{GS}=0V$	-	-	1.4	V
Reverse recovery time		$t_{rr}$	$I_{DR}=7.5A, V_{GS}=0V,$	-	80	-	ns
Reverse recovery charge		$Q_{rr}$	$dI_{DR} / dt = 100 A / \mu s$	-	0.22	-	$\mu C$

Note 1.Repeativity rating :pulse width limited by junction temperature

2.L=0.6mH  $I_{AS}=33A, V_{DD}=25V, R_G=25\Omega,$  Starting  $T_J=25^\circ C$

3. $I_{SD}\leq 33.A, di/dt\leq 300A/us, V_{DD}<BV_{DSS},$  STARTING  $T_J=25^\circ C$

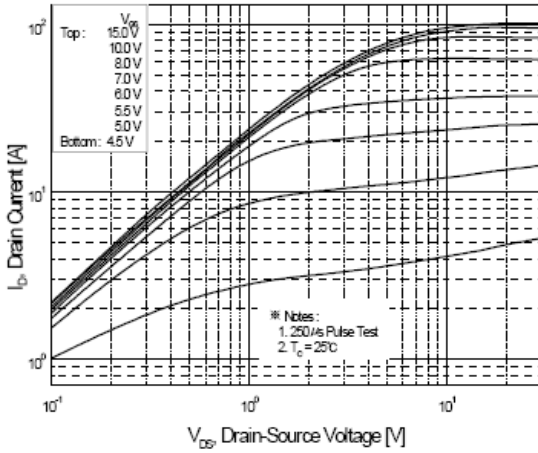
4.Pulse Test:Pulse Width $\leq 300us,$ Duty Cycles $\leq 2\%$

5. Essentially independent of operating temperature.

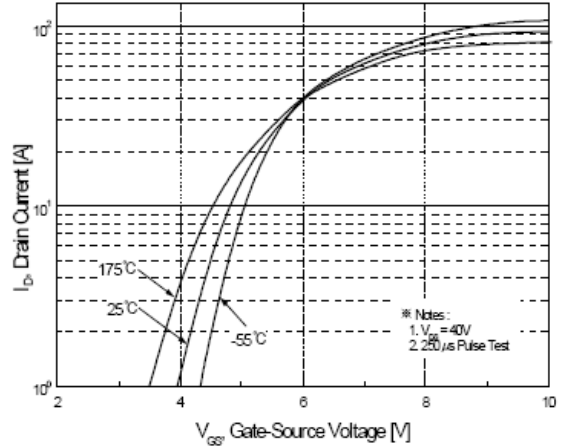
This transistor is an electrostatic sensitive device

Please handle with caution

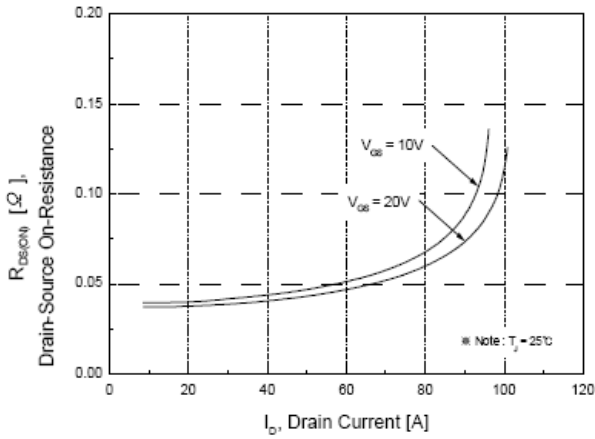
**Typical Characteristics**



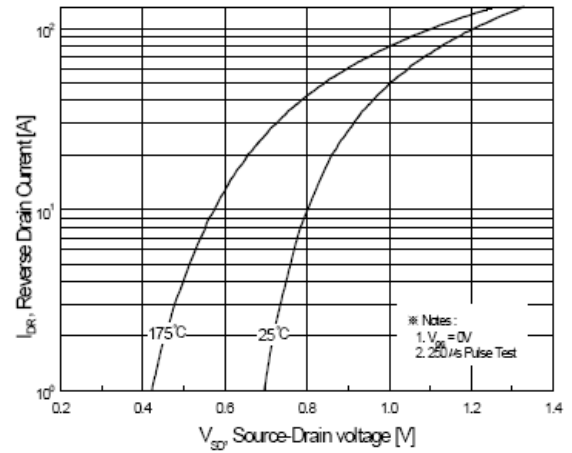
**Figure 1. On-Region Characteristics**



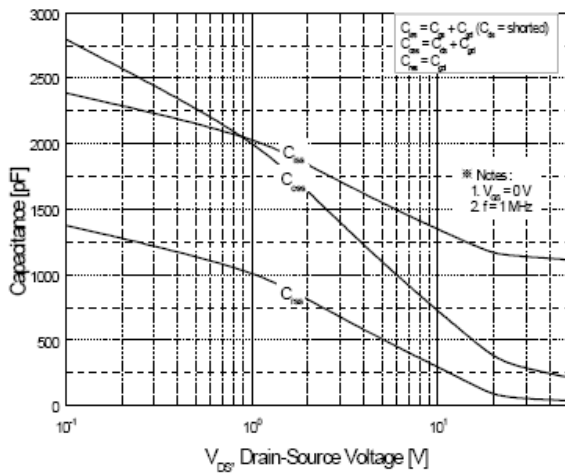
**Figure 2. Transfer Characteristics**



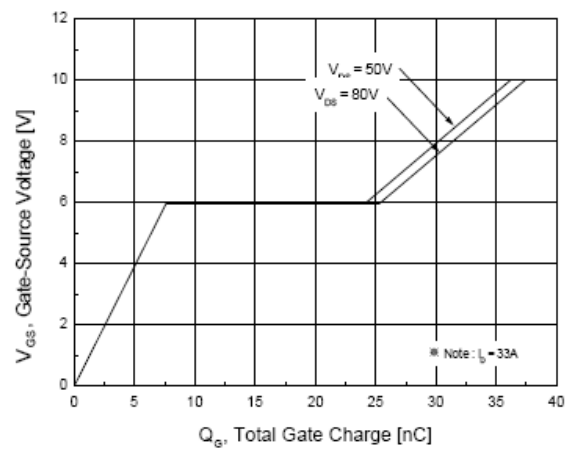
**Figure 3. On-Resistance Variation vs. Drain Current and Gate Voltage**



**Figure 4. Body Diode Forward Voltage Variation vs. Source Current and Temperature**

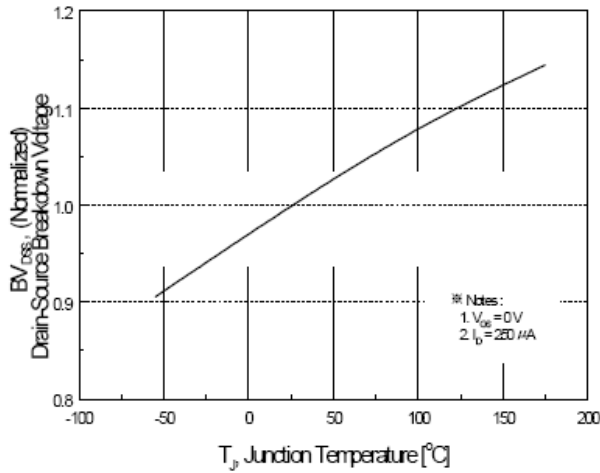


**Figure 5. Capacitance Characteristics**

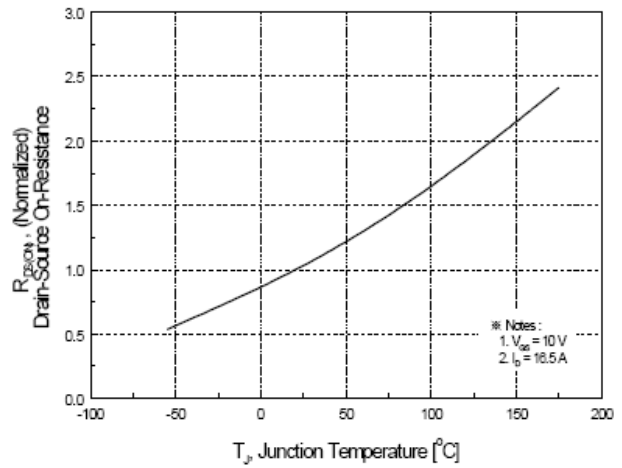


**Figure 6. Gate Charge Characteristics**

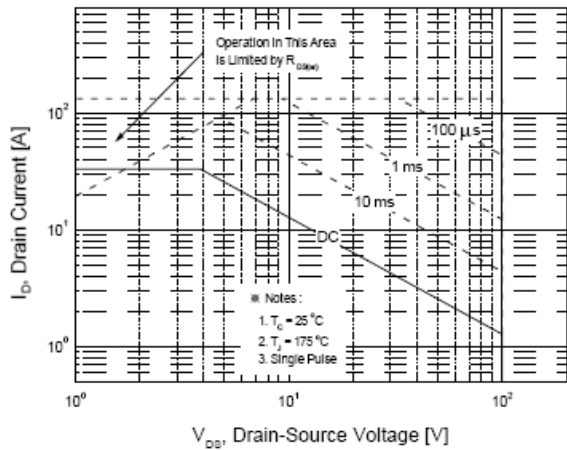




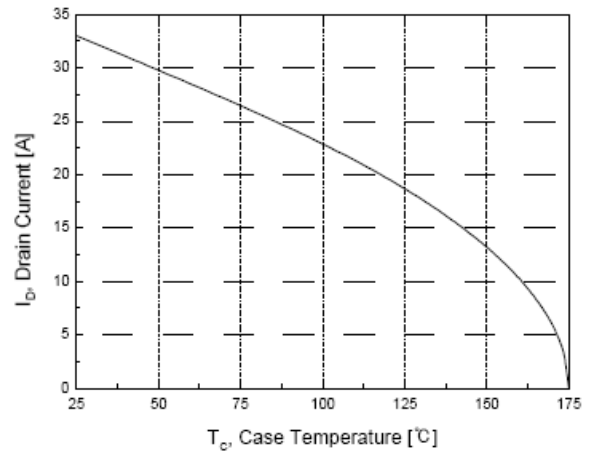
**Figure 7. Breakdown Voltage Variation vs. Temperature**



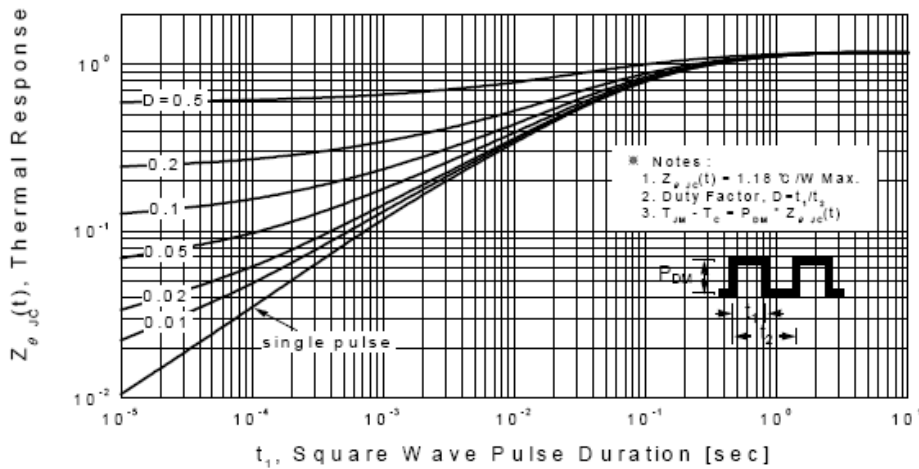
**Figure 8. On-Resistance Variation vs. Temperature**



**Figure 9. Maximum Safe Operating Area**



**Figure 10. Maximum Drain Current vs. Case Temperature**



**Figure 11. Transient Thermal Response Curve**

**TO-220 Package Dimension**

